Notice of References Cited

Application/Control No. 10/016,241	Applicant(s)/Patent Reexamination FUJIWARA, YOSH	
Examiner	Art Unit	
Fadey S. Jabr	3639	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0124666 A1	09-2002	Navarro et al.	73/865.8
*	В	US-2002/0035495 A1	03-2002	Spira et al.	705/7
*	C	US-2001/0007093 A1	07-2001	Nguyen, John H.	702/182
*	D	US-6,880,128 B2	04-2005	Nguyen, John H.	715/744
	Е	US-			
	F	US-			
	G	US-	-		
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L.	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2189321 A	10-1987	United Kingdom	FUJIWARA et al.	G07C 3/00
	0	EP 0972982 A2	07-1999	-	Hiroshi et al.	F16T 1/48
	Р	EP 0892326 A2	01-1999	-	Nguyen et al.	G05B 19/042
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.